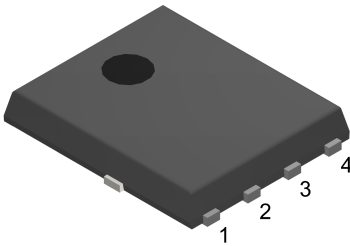
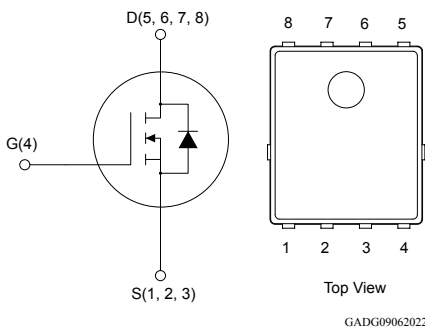


N-channel 40 V, 1.1 mΩ max., 290 A STripFET F8 Power MOSFET in a PowerFLAT 5x6 package


PowerFLAT 5x6


Features

Order code	V_{DS}	$R_{DS(on)}$ max.	I_D
STL300N4F8	40 V	1.1 mΩ	290 A

- MSL1 grade
- 175 °C maximum operating junction temperature
- 100% avalanche tested
- Low gate charge Q_G

Applications

- Industrial tools, motor drives and equipment
- Industrial motor control
- Power supplies and converters

Description

The **STL300N4F8** is a 40 V N-channel enhancement mode Power MOSFET designed in STripFET F8 technology featuring an enhanced trench gate structure.

It ensures a state-of-the-art of figure of merit for very low on-state resistance while reducing internal capacitances and gate charge for faster and more efficient switching.



Product status link

[STL300N4F8](#)

Product summary

Order code	STL300N4F8
Marking⁽¹⁾	300N4F8
Package	PowerFLAT 5x6
Packing	Tape and reel

1. For engineering samples marking, see Section 3.3: PowerFLAT 5x6 marking information.

1 Electrical ratings

Table 1. Absolute maximum ratings (at $T_C = 25\text{ °C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	40	V
V_{GS}	Gate-source voltage	± 20	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25\text{ °C}$ ⁽²⁾	290	A
	Drain current (continuous) at $T_C = 100\text{ °C}$ ⁽²⁾	205	
	Drain current (continuous) at $T_C = 25\text{ °C}$ ⁽³⁾	120	
$I_{DM}^{(1)(2)(4)}$	Drain current (pulsed), $t_p = 10\text{ }\mu\text{s}$	1160	A
P_{TOT}	Total power dissipation at $T_C = 25\text{ °C}$	167	W
I_{AS}	Single pulse avalanche current (pulse width limited by maximum junction temperature)	60	A
E_{AS}	Single pulse avalanche energy (starting $T_J = 25\text{ °C}$, $I_D = 60\text{ A}$, $R_{Gmin} = 25\text{ }\Omega$)	490	mJ
T_J	Operating junction temperature range	-55 to 175	$^{\circ}\text{C}$
T_{stg}	Storage temperature range		$^{\circ}\text{C}$

1. Specified by design, not tested in production.
2. This is the theoretical current value only related to the silicon.
3. This current value is limited by package.
4. Pulse width is limited by safe operating area.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{thJA}^{(1)}$	Thermal resistance, junction-to-ambient (on 2s2p FR-4 board vertical in still area)	16.5	$^{\circ}\text{C/W}$
R_{thJC}	Thermal resistance, junction-to-case	0.9	$^{\circ}\text{C/W}$

1. Defined according to JEDEC standards (JESD51-5, -7).

2 Electrical characteristics

$T_J = 25\text{ °C}$ unless otherwise specified.

Table 3. On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}$, $I_D = 1\text{ mA}$	40			V
I_{DSS}	Zero gate voltage drain current	$V_{DS} = 40\text{ V}$, $V_{GS} = 0\text{ V}$			1	μA
		$V_{DS} = 40\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 125\text{ °C}^{(1)}$			100	
I_{GSS}	Gate-body leakage current	$V_{GS} = 20\text{ V}$, $V_{DS} = 0\text{ V}$			100	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	2		4	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}$, $I_D = 60\text{ A}$		0.85	1.1	m Ω
$R_G^{(1)}$	Gate resistance			0.6		Ω

1. Specified by design and evaluated by characterization, not tested in production.

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}^{(1)}$	Input capacitance	$V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GS} = 0\text{ V}$	-	4950	-	pF
$C_{oss}^{(1)}$	Output capacitance		-	1500	-	pF
$C_{rss}^{(1)}$	Reverse transfer capacitance		-	25	-	pF
$Q_g^{(1)}$	Total gate charge	$V_{DD} = 20\text{ V}$, $I_D = 60\text{ A}$, $V_{GS} = 0\text{ to }10\text{ V}$	-	65	-	nC
$Q_{gs}^{(1)}$	Gate-source charge		-	25	-	nC
$Q_{gd}^{(1)}$	Gate-drain charge		-	9	-	nC
$Q_{g(sync)}$	Total gate charge, sync. MOSFET	$V_{DS} = 0.1\text{ V}$, $V_{GS} = 0\text{ to }10\text{ V}$	-	56	-	nC
Q_{oss}	Output charge	$V_{DD} = 20\text{ V}$, $V_{GS} = 0\text{ V}$	-	86	-	nC

1. Specified by design and evaluated by characterization, not tested in production.

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}^{(1)}$	Turn-on delay time	$V_{DD} = 20\text{ V}$, $I_D = 60\text{ A}$, $R_G = 4.7\text{ }\Omega$, $V_{GS} = 10\text{ V}$	-	17.5	-	ns
$t_r^{(1)}$	Rise time		-	8	-	ns
$t_{d(off)}^{(1)}$	Turn-off delay time		-	31	-	ns
$t_f^{(1)}$	Fall time		-	6.5	-	ns

1. Specified by design and evaluated by characterization, not tested in production.

Table 6. Source-drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}^{(1)(2)}$	Forward on current (continuous)	$T_C = 25\text{ °C}$	-		121	A
V_{SD}	Forward on voltage	$I_{SD} = 60\text{ A}, V_{GS} = 0\text{ V}$	-		1.1	V
$t_{rr}^{(1)}$	Reverse recovery time	$I_D = 60\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, V_{DD} = 32\text{ V}$	-	57		ns
$Q_{rr}^{(1)}$	Reverse recovery charge		-	70		nC
$I_{RRM}^{(1)}$	Reverse recovery current		-	9		A

1. Specified by design and evaluated by characterization, not tested in production.
2. This is the theoretical current value only related to the silicon.

2.1 Electrical characteristics (curves)

Figure 1. Total power dissipation

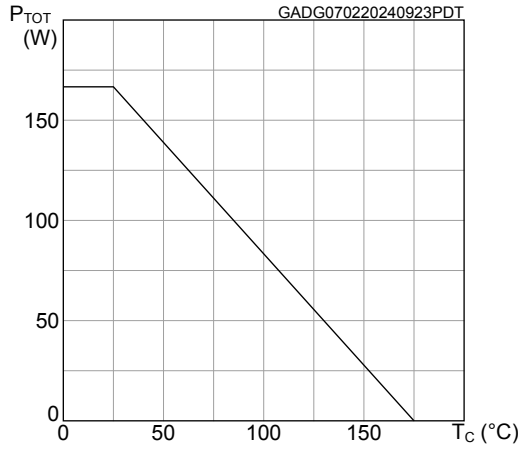


Figure 2. Drain current vs case temperature

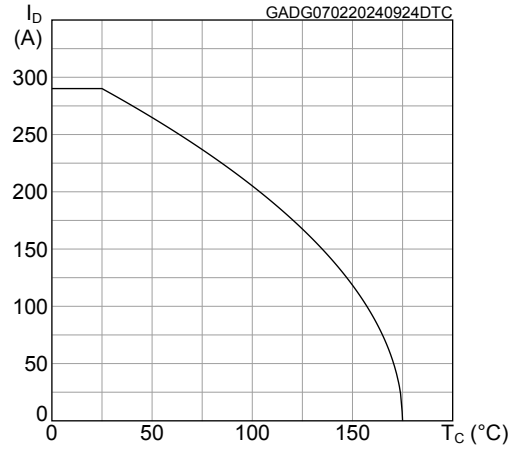


Figure 3. Safe operating area

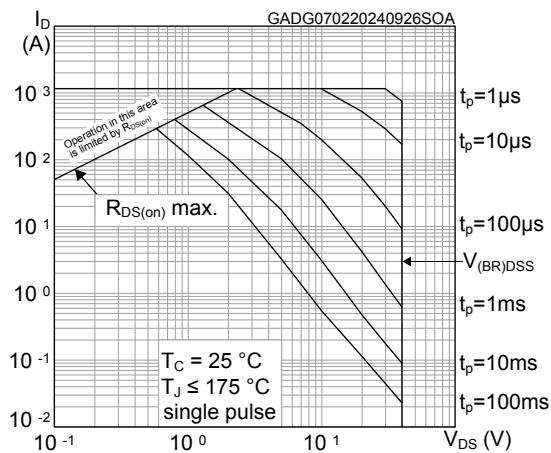


Figure 4. Normalized transient thermal impedance

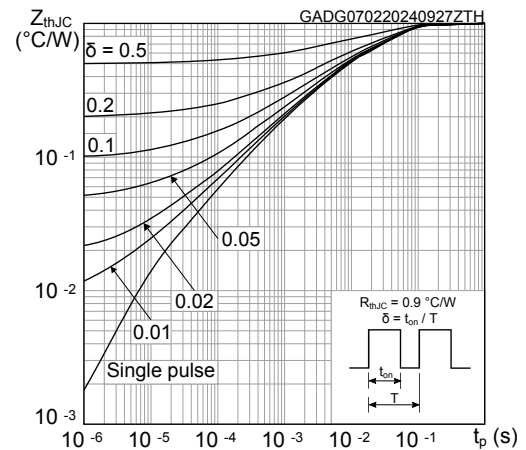


Figure 5. Avalanche characteristics

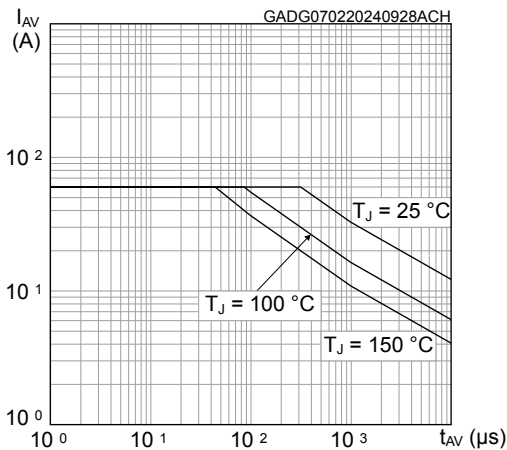


Figure 6. Avalanche energy

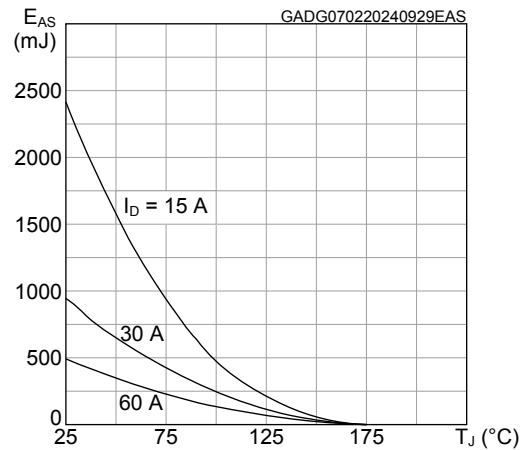


Figure 7. Normalized on-resistance vs temperature

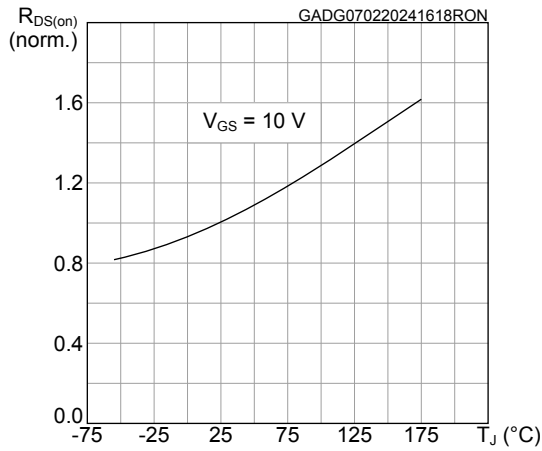


Figure 8. Normalized gate threshold voltage vs temperature

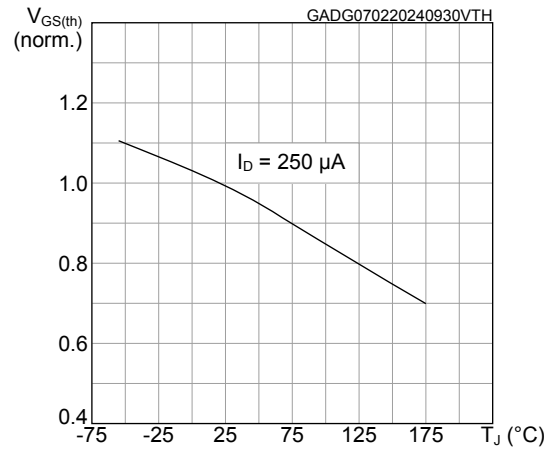


Figure 9. Typical reverse diode forward characteristics

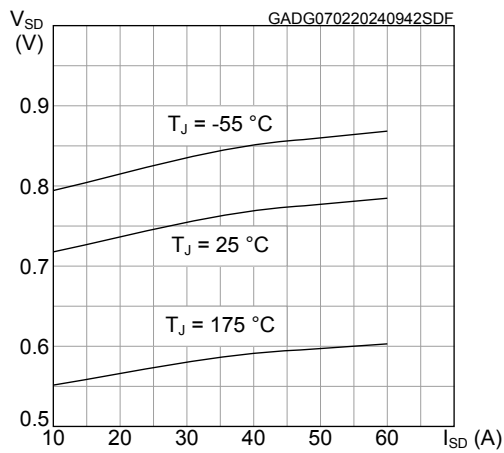


Figure 10. Normalized $V_{(BR)DSS}$ vs temperature

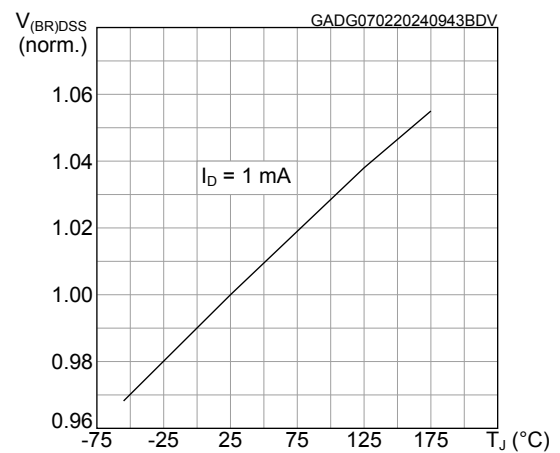


Figure 11. Typical output characteristics

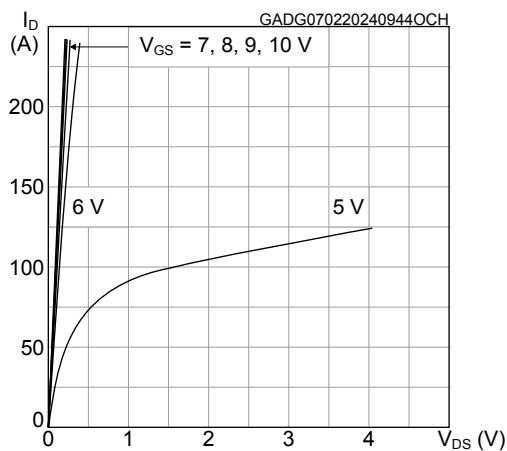


Figure 12. Typical transfer characteristics

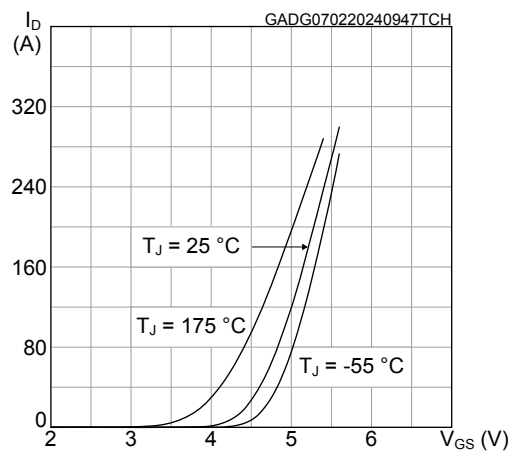


Figure 13. Typical drain-source on-resistance

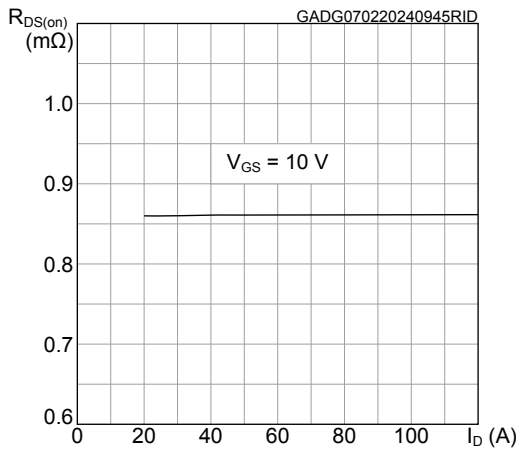


Figure 14. Typical on-resistance vs gate-source voltage

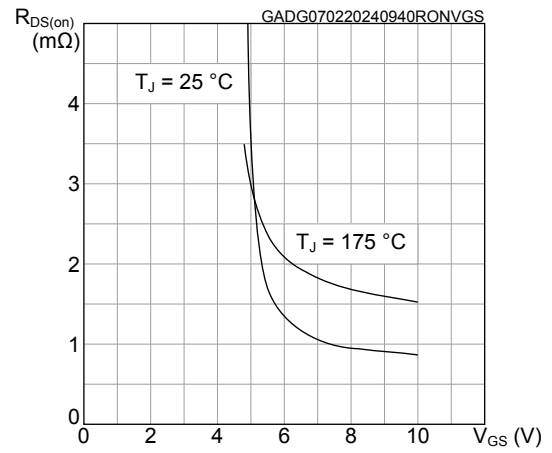


Figure 15. Typical gate charge characteristics

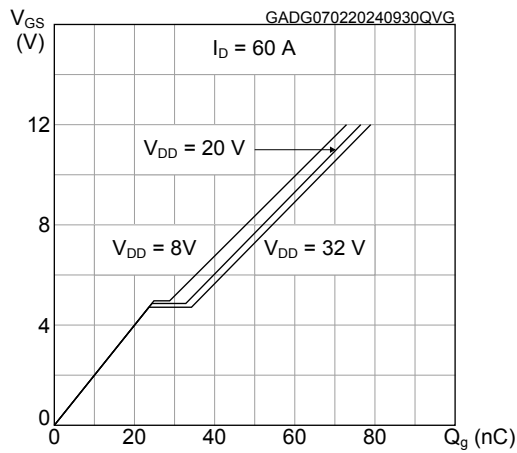
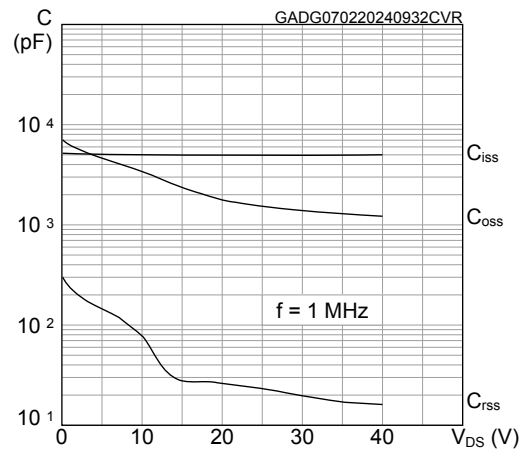


Figure 16. Typical capacitance characteristics

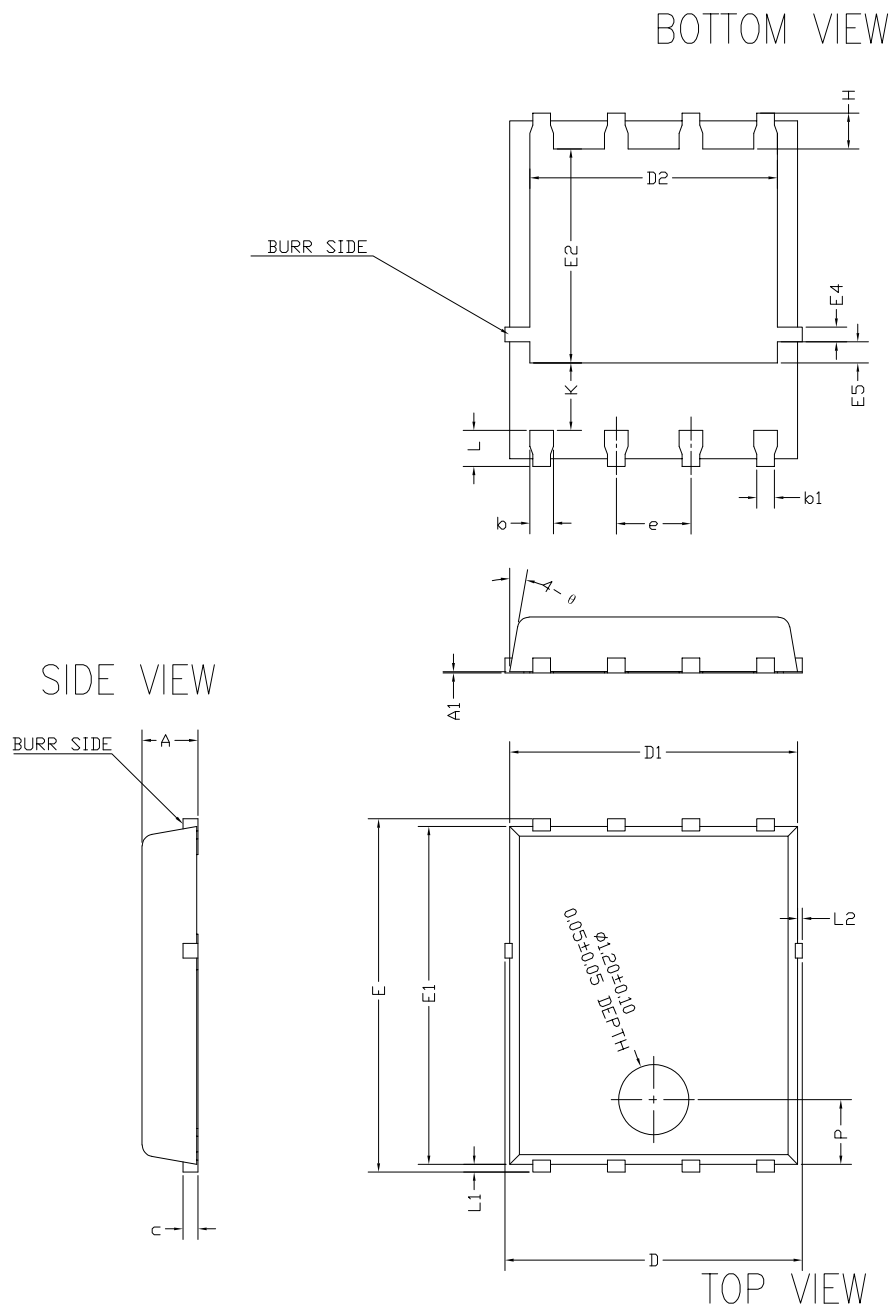


3 Package information

In order to meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

3.1 PowerFLAT 5x6 type B package information

Figure 17. PowerFLAT 5x6 type B package outline

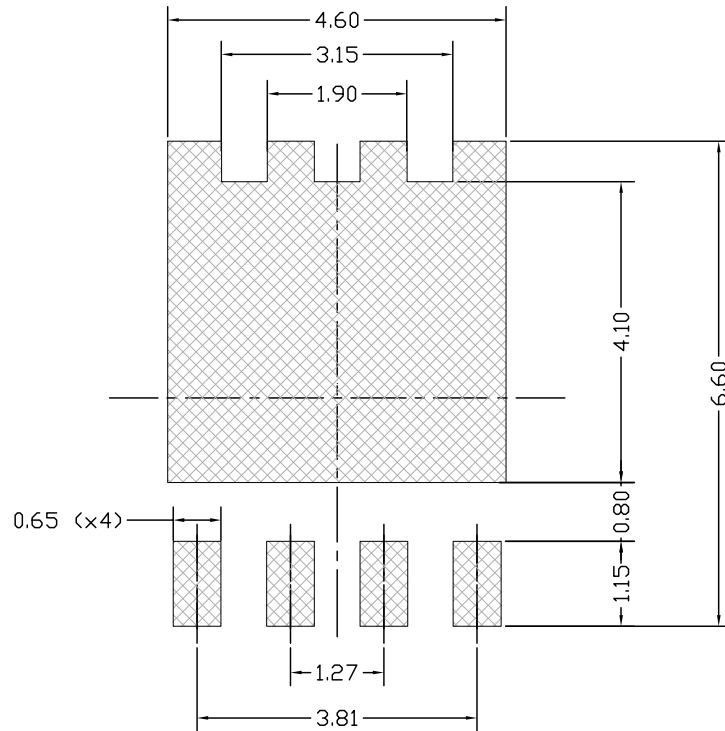


Drawing_8472137_typeB rev5

Table 7. PowerFLAT 5x6 type B mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.90	0.95	1.00
A1		0.02	
b	0.35	0.40	0.45
b1		0.30	
c	0.21	0.25	0.34
D	4.80		5.10
D1	4.80	4.90	5.00
D2	4.01	4.21	4.31
e	1.17	1.27	1.37
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.54	3.64	3.74
E4	0.15	0.25	0.35
E5	0.26	0.36	0.46
H	0.51	0.61	0.71
K	0.95		
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
L2			0.10
P	1.00	1.10	1.20
θ	8°	10°	12°

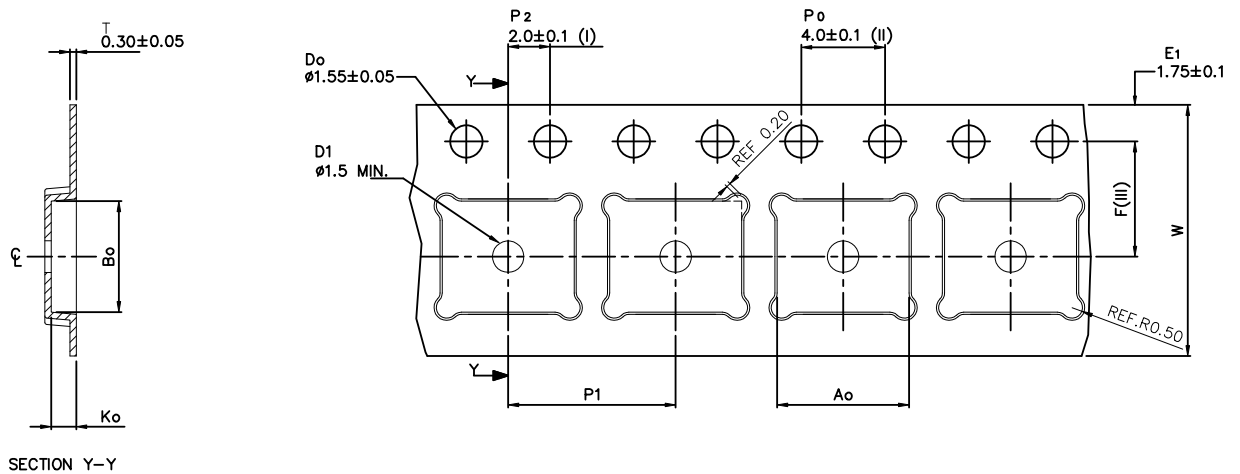
Figure 18. PowerFLAT 5x6 recommended footprint (dimensions are in mm)



Footprint_8472137_typeB rev5

3.2 PowerFLAT 5x6 packing information

Figure 19. PowerFLAT 5x6 tape (dimensions are in mm)



SECTION Y-Y

Ao	6.30	+/- 0.1
Bo	5.30	+/- 0.1
Ko	1.20	+/- 0.1
F	5.50	+/- 0.1
P1	8.00	+/- 0.1
W	12.00	+/- 0.3

(I) Measured from centreline of sprocket hole to centreline of pocket.

(II) Cumulative tolerance of 10 sprocket holes is ± 0.20 .

(III) Measured from centreline of sprocket hole to centreline of pocket

Base and bulk quantity 3000 pcs
All dimensions are in millimeters

8234350_Tape_rev_C

Figure 20. PowerFLAT 5x6 package orientation in carrier tape

Pin 1 identification

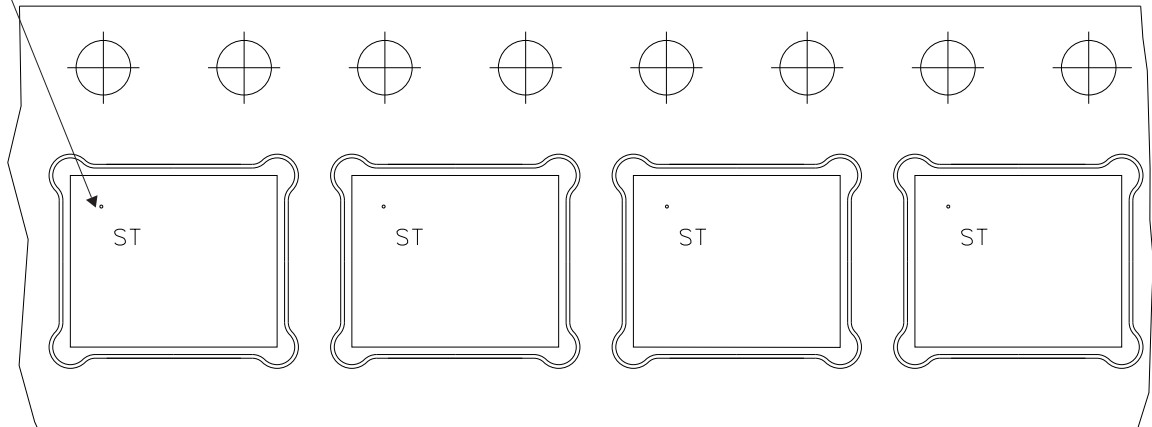
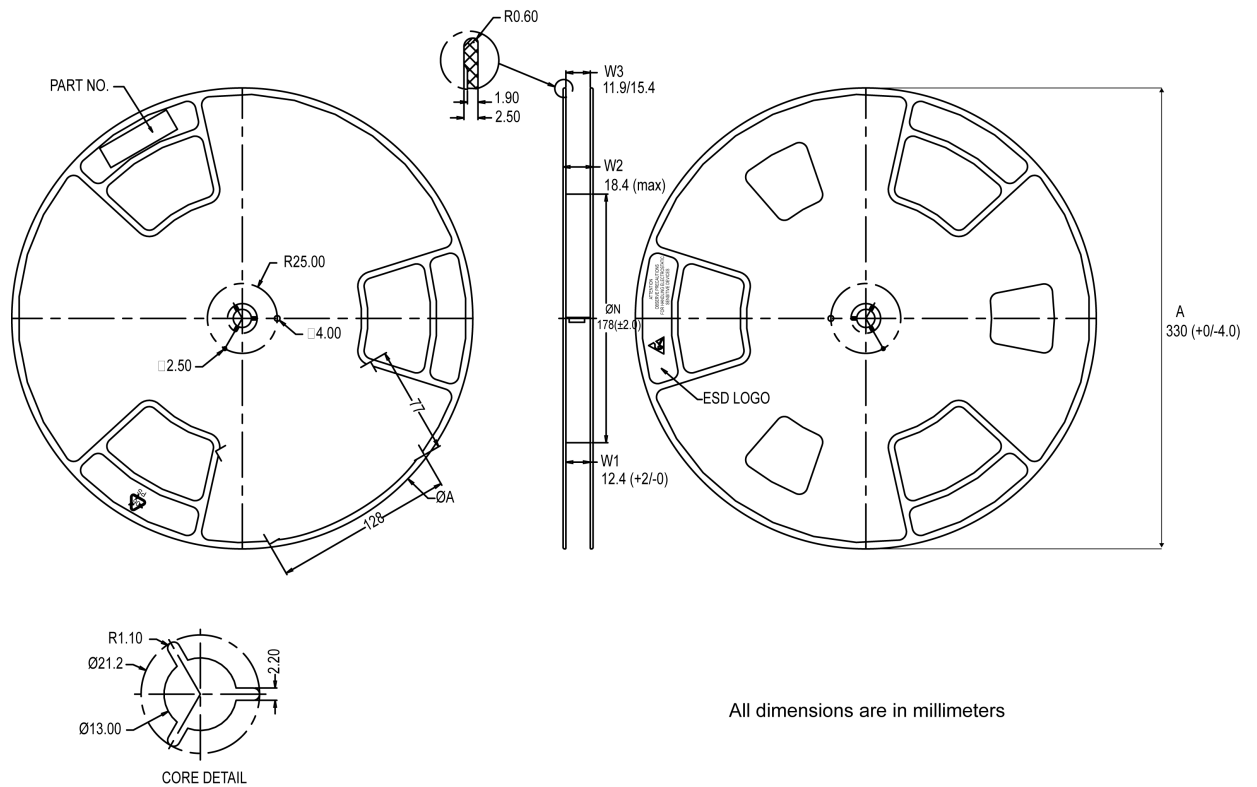


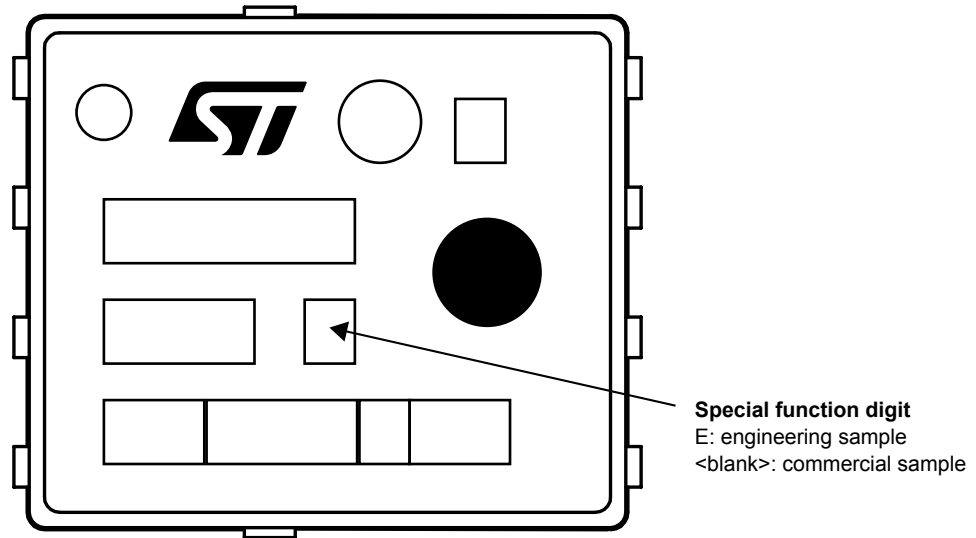
Figure 21. PowerFLAT 5x6 reel



8234350_Reel_rev_C

3.3 PowerFLAT 5x6 marking information

Figure 22. PowerFLAT 5x6 marking information



Note: *Engineering Samples: these samples can be clearly identified by a dedicated special symbol in the marking of each unit. These samples are intended to be used for electrical compatibility evaluation only; usage for any other purpose may be agreed only upon written authorization by ST. ST is not liable for any customer usage in production and/or in reliability qualification trials.*
Commercial Samples: fully qualified parts from ST standard production with no usage restrictions.

Revision history

Table 8. Document revision history

Date	Revision	Changes
12-Feb-2024	1	First release.
18-Jun-2024	2	Modified Applications and Figure 3. Safe operating area.

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3	Package information	8
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